Product data sheet

1. General description

The 74LV4051 is an 8-channel analog multiplexer/demultiplexer with three digital select inputs (S0 to S2), an active-LOW enable input (\overline{E}), eight independent inputs/outputs (Y0 to Y7) and a common input/output (Z). It is a low-voltage Si-gate CMOS device that is pin and function compatible with 74HC4051 and 74HCT4051. With \overline{E} LOW, one of the eight switches is selected (low impedance ON-state) by S0 to S2. With \overline{E} HIGH, all switches are in the high-impedance OFF-state, independent of S0 to S2.

 V_{CC} and GND are the supply voltage pins for the digital control inputs (S0 to S2, and \overline{E}). The V_{CC} to GND ranges are 1.0 V to 6.0 V. The analog inputs/outputs (Y0 to Y7, and Z) can swing between V_{CC} as a positive limit and V_{EE} as a negative limit. $V_{CC} - V_{EE}$ may not exceed 6.0 V. For operation as a digital multiplexer/demultiplexer, V_{EE} is connected to GND (typically ground).

2. Features and benefits

- Optimized for low-voltage applications: 1.0 V to 6.0 V
- Accepts TTL input levels between $V_{CC} = 2.7$ V and $V_{CC} = 3.6$ V
- Low ON resistance:
 - 145 Ω (typical) at V_{CC} V_{EE} = 2.0 V
 - 80 Ω (typical) at V_{CC} V_{EE} = 3.0 V
 - 60 Ω (typical) at V_{CC} V_{EE} = 4.5 V
- Logic level translation:
 - ◆ To enable 3 V logic to communicate with ±3 V analog signals
- Typical 'break before make' built in
- ESD protection:
 - ◆ HBM JESD22-A114E exceeds 2000 V
 - MM JESD22-A115-A exceeds 200 V
- Multiple package options
- Specified from –40 °C to +85 °C and from –40 °C to +125 °C



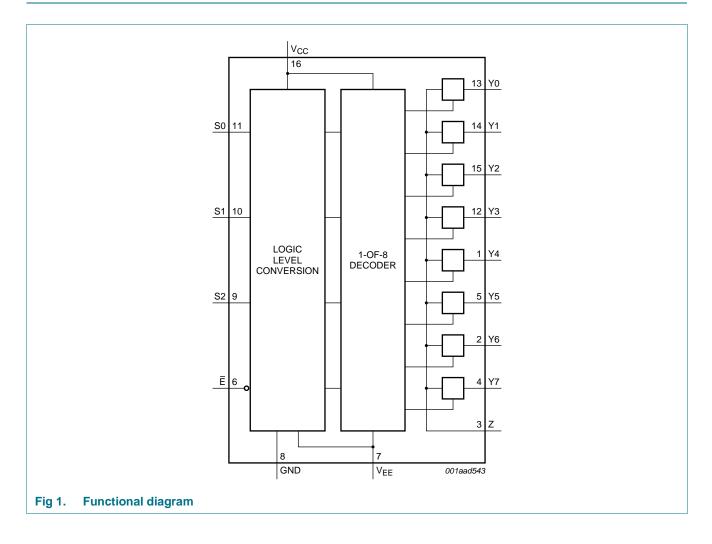
8-channel analog multiplexer/demultiplexer

3. Ordering information

Table 1. Ordering information

Type number	Package									
	Temperature range	Name	Description	Version						
74LV4051N	–40 °C to +125 °C	DIP16	plastic dual in-line package; 16 leads (300 mil)	SOT38-4						
74LV4051D	–40 °C to +125 °C	SO16	plastic small outline package; 16 leads; body width 3.9 mm	SOT109-1						
74LV4051DB	–40 °C to +125 °C	SSOP16	plastic shrink small outline package; 16 leads; body width 5.3 mm	SOT338-1						
74LV4051PW	–40 °C to +125 °C	TSSOP16	plastic thin shrink small outline package; 16 leads; body width 4.4 mm	SOT403-1						
74LV4051BQ	–40 °C to +125 °C	DHVQFN16	plastic dual in-line compatible thermal enhanced very thin quad flat package; no leads; 16 terminals; body $2.5 \times 3.5 \times 0.85$ mm	SOT763-1						

4. Functional diagram



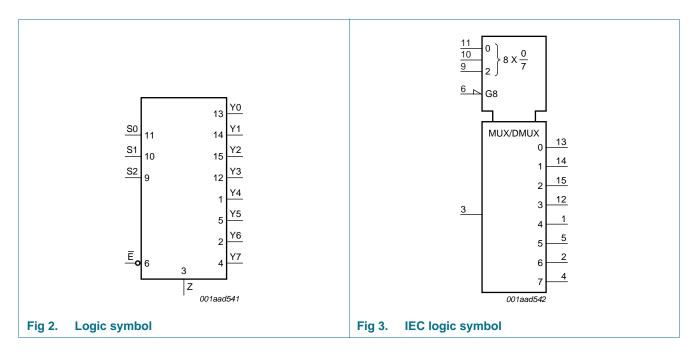
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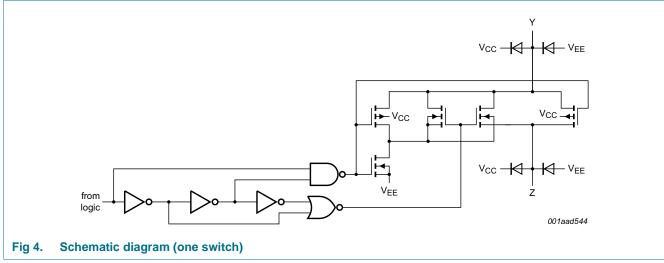
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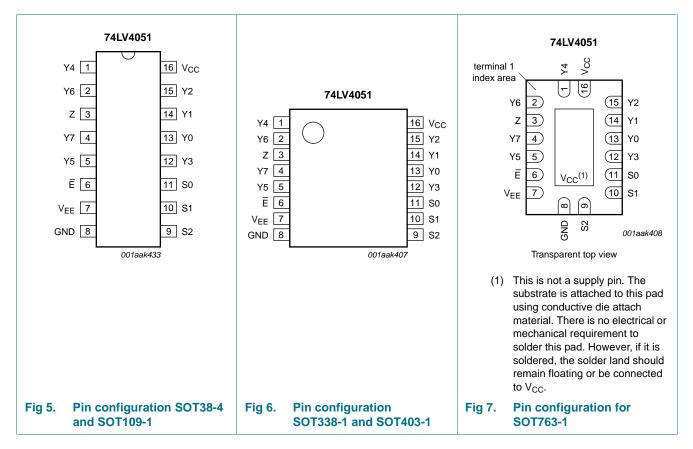




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Pinning information 5.

5.1 Pinning



5.2 Pin description

Table 2. Pin description		
Symbol	Pin	Description
Ē	6	enable input (active LOW)
V _{EE}	7	supply voltage
GND	8	ground supply voltage
S0, S1, S2	11, 10, 9	select input
Y0, Y1, Y2, Y3, Y4, Y5, Y6, Y7	13, 14, 15, 12, 1, 5, 2, 4	independent input or output
Z	3	common output or input
V _{CC}	16	supply voltage

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6. Functional description

6.1 Function table

 Table 3.
 Function table^[1]

Input				Channel ON
Ē	S2	S1	S0	
L	L	L	L	Y0 to Z
L	L	L	Н	Y1 to Z
L	L	Н	L	Y2 to Z
L	L	Н	Н	Y3 to Z
L	Н	L	L	Y4 to Z
L	Н	L	Н	Y5 to Z
L	Н	Н	L	Y6 to Z
L	Н	Н	Н	Y7 to Z
Н	Х	Х	Х	switches off

[1] H = HIGH voltage level;

L = LOW voltage level;

X = don't care.

7. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to V_{SS} = 0 V (ground).

Symbol	Parameter	Conditions		Min	Max	Unit
V _{CC}	supply voltage		[1]	-0.5	+7.0	V
I _{IK}	input clamping current	$V_{I} < -0.5$ V or $V_{I} > V_{CC}$ + 0.5 V	[2]	-	±20	mA
I _{SK}	switch clamping current	V_{SW} < –0.5 V or V_{SW} > V_{CC} + 0.5 V	[2]	-	±20	mA
I _{SW}	switch current	V_{SW} > -0.5 V or V_{SW} < V_{CC} + 0.5 V; source or sink current	[2]	-	±25	mA
T _{stg}	storage temperature			-65	+150	°C
P _{tot}	total power dissipation	$T_{amb} = -40 \ ^{\circ}C \ to +125 \ ^{\circ}C$	[3]			
		DIP16 package		-	750	mW
		SO16 package		-	500	mW
		TSSOP16 package		-	500	mW
		DHVQFN16 package		-	500	mW

[1] To avoid drawing V_{CC} current out of terminal Z, when switch current flows into terminals Yn, the voltage drop across the bidirectional switch must not exceed 0.4 V. If the switch current flows into terminal Z, no V_{CC} current will flow out of terminals Yn, and in this case there is no limit for the voltage drop across the switch, but the voltages at Yn and Z may not exceed V_{CC} or V_{EE} .

[2] The minimum input voltage rating may be exceeded if the input current rating is observed.

[3] For DIP16 packages: above 70 °C the value of P_{tot} derates linearly with 12 mW/K.
 For SO16 packages: above 70 °C the value of P_{tot} derates linearly with 8 mW/K.
 For SSOP16 and TSSOP16 packages: above 60 °C the value of P_{tot} derates linearly with 5.5 mW/K.
 For DHVQFN16 packages: above 60 °C the value of P_{tot} derates linearly with 4.5 mW/K.

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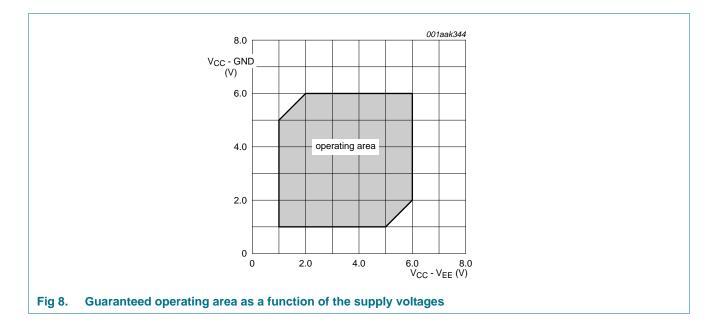
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Recommended operating conditions 8.

Table 5. Recommended operating conditions ^[1]										
Symbol	Parameter	Conditions	Min	Тур	Max	Unit				
V _{CC}	supply voltage	see Figure 8	1	3.3	6	V				
VI	input voltage		0	-	V _{CC}	V				
V _{SW}	switch voltage		0	-	V _{CC}	V				
T _{amb}	ambient temperature	in free air	-40	-	+125	°C				
$\Delta t / \Delta V$	input transition rise and fall rate	V _{CC} = 1.0 V to 2.0 V	-	-	500	ns/V				
		V_{CC} = 2.0 V to 2.7 V	-	-	200	ns/V				
		V _{CC} = 2.7 V to 3.6 V	-	-	100	ns/V				

[1] The static characteristics are guaranteed from V_{CC} = 1.2 V to 6.0 V, but LV devices are guaranteed to function down to V_{CC} = 1.0 V (with input levels GND or V_{CC}).



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9. Static characteristics

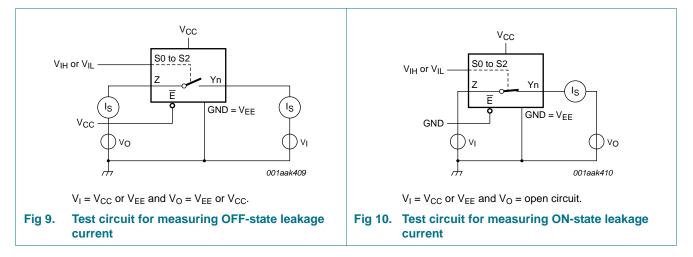
Table 6. Static characteristics

At recommended operating conditions. Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	-40	°C to +8	5 °C	–40 °C to	o +125 °C	Unit
			Min	Typ[1]	Max	Min	Max	
VIH	HIGH-level input voltage	V _{CC} = 1.2 V	0.9	-	-	0.9	-	V
		V _{CC} = 2.0 V	1.4	-	-	1.4	-	V
		V_{CC} = 2.7 V to 3.6 V	2.0	-	-	2.0	-	V
		V _{CC} = 4.5 V	3.15	-	-	3.15	-	V
		V _{CC} = 6.0 V	4.20	-	-	4.20	-	V
VIL	LOW-level input voltage	V _{CC} = 1.2 V	-	-	0.3	-	0.3	V
		V _{CC} = 2.0 V	-	-	0.6	-	0.6	V
		V_{CC} = 2.7 V to 3.6 V	-	-	0.8	-	0.8	V
		V _{CC} = 4.5 V	-	-	1.35	-	1.35	V
		V _{CC} = 6.0 V	-	-	1.80	-	1.80	V
li	input leakage current	$V_{I} = V_{CC}$ or GND						
	input leakage current	V _{CC} = 3.6 V	-	-	1.0	-	1.0	μΑ
		V _{CC} = 6.0 V	-	-	2.0		μΑ	
S(OFF)	OFF-state leakage current	$V_I = V_{IH}$ or V_{IL} ; see Figure 9						
		V _{CC} = 3.6 V	-	-	1.0	-	1.0	μΑ
		$V_{CC} = 6.0 V$	-	-	2.0	-	2.0	μΑ
S(ON)	ON-state leakage current	$V_I = V_{IH}$ or V_{IL} ; see Figure 10						
		V _{CC} = 3.6 V	-	-	1.0	-	1.0	μΑ
		$V_{CC} = 6.0 V$	-	-	2.0	-	2.0	μΑ
lcc	supply current	$V_I = V_{CC}$ or GND; $I_O = 0$ A						
		V _{CC} = 3.6 V	-	-	20	-	40	μΑ
		$V_{CC} = 6.0 V$	-	-	40	-	80	μΑ
∆l _{CC}	additional supply current	per input; V _I = V _{CC} – 0.6 V; V _{CC} = 2.7 V to 3.6 V	-	-	500	-	850	μA
CI	input capacitance		-	3.5	-	-	-	pF
C _{sw}	switch capacitance	independent pins Yn	-	5	-	-	-	pF
		common pin Z	-	25	-	-	-	pF

[1] Typical values are measured at $T_{amb} = 25 \ ^{\circ}C$.

8-channel analog multiplexer/demultiplexer



9.1 Test circuits

9.2 ON resistance

Table 7. ON resistance

At recommended operating conditions; voltages are referenced to GND (ground = 0 V); for graphs see $\frac{Figure 11}{Figure 12}$.

Symbol	Parameter	Conditions		-40	°C to +8	5 °C	-40 °C t	o +125 °C	Unit
				Min	Typ <mark>[1]</mark>	Max	Min	Max	-
R _{ON(peak)}	ON resistance (peak)	$V_{I} = 0 V \text{ to } V_{CC} - V_{EE}$							
		V_{CC} = 1.2 V; I_{SW} = 100 μ A	[2]	-	-	-	-	-	Ω
		V_{CC} = 2.0 V; I_{SW} = 1000 μ A		-	145	325	-	375	Ω
		V_{CC} = 2.7 V; I_{SW} = 1000 μ A		-	90	200	-	235	Ω
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V;}$ $I_{SW} = 1000 \ \mu\text{A}$		-	80	180	-	210	Ω
		V_{CC} = 4.5 V; I _{SW} = 1000 µA		-	60	135	-	160	Ω
		V_{CC} = 6.0 V; I_{SW} = 1000 μ A		-	55	125	-	145	Ω
ΔR_{ON}	ON resistance mismatch	$V_I = 0 V \text{ to } V_{CC} - V_{EE}$							
	between channels	V_{CC} = 1.2 V; I_{SW} = 100 μ A	[2]	-	-	-	-	-	Ω
		V_{CC} = 2.0 V; I_{SW} = 1000 μ A		-	5	-	-	-	Ω
		V_{CC} = 2.7 V; I_{SW} = 1000 μ A		-	4	-	-	-	Ω
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V};$ $I_{SW} = 1000 \mu\text{A}$		-	4	-	-	-	Ω
		$V_{CC} = 4.5 \text{ V}; \text{ I}_{SW} = 1000 \mu\text{A}$		-	3	-	-	-	Ω
		$V_{CC} = 6.0 \text{ V}; I_{SW} = 1000 \mu\text{A}$		-	2	-	-	-	Ω

8-channel analog multiplexer/demultiplexer

Table 7. ON resistance ...continued

At recommended operating conditions; voltages are referenced to GND (ground = 0 V); for graphs see $\frac{Figure 11}{Figure 12}$.

Symbol	Parameter	Conditions		-40	°C to +8	5 °C	-40 °C to	o +125 °C	Unit
				Min	Typ[1]	Max	Min	Max	
R _{ON(rail)}	ON resistance (rail)	V _I = GND							
		V_{CC} = 1.2 V; I_{SW} = 100 μ A	[2]	-	225	-	-	-	Ω
		V_{CC} = 2.0 V; I_{SW} = 1000 μ A		-	110	235	-	270	Ω
		V_{CC} = 2.7 V; I_{SW} = 1000 μ A		-	70	145	-	165	Ω
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V};$ $I_{SW} = 1000 \ \mu\text{A}$		-	60	130	-	150	Ω
		V_{CC} = 4.5 V; I_{SW} = 1000 μ A		-	45	100	-	115	Ω
		$V_{CC} = 6.0 \text{ V}; \text{ I}_{SW} = 1000 \mu\text{A}$		-	40	85	-	100	Ω
R _{ON(rail)}	ON resistance (rail)	$V_I = V_{CC} - V_{EE}$							
		V_{CC} = 1.2 V; I_{SW} = 100 μ A	[2]	-	250	-	-	-	Ω
		V_{CC} = 2.0 V; I_{SW} = 1000 μ A		-	120	320	-	370	Ω
		V_{CC} = 2.7 V; I_{SW} = 1000 μ A		-	75	195	-	225	Ω
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V;}$ $I_{SW} = 1000 \mu\text{A}$		-	70	175	-	205	Ω
		V_{CC} = 4.5 V; I_{SW} = 1000 μ A		-	50	130	-	150	Ω
		$V_{CC} = 6.0 \text{ V}; \text{ I}_{SW} = 1000 \mu\text{A}$		-	45	120	-	135	Ω

[1] Typical values are measured at $T_{amb} = 25 \ ^{\circ}C$.

[2] When supply voltages (V_{CC} – V_{EE}) near 1.2 V the analog switch ON resistance becomes extremely non-linear. When using a supply of 1.2 V, it is recommended to use these devices only for transmitting digital signals.

8-channel analog multiplexer/demultiplexer

9.3 On resistance waveform and test circuit

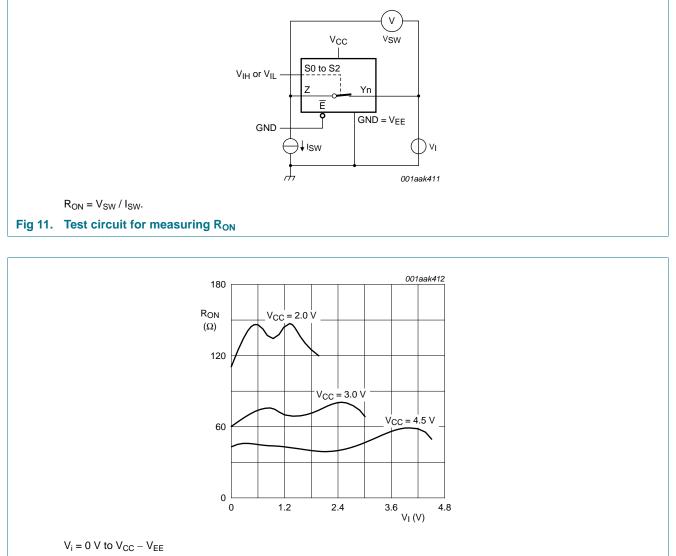


Fig 12. Typical R_{ON} as a function of input voltage

8-channel analog multiplexer/demultiplexer

10. Dynamic characteristics

Table 8. Dynamic characteristics

Voltages are referenced to GND (ground = 0 V). For test circuit see Figure 15.

Symbol	Parameter	Conditions		-40	°C to +85	5 °C	_40 °C t	o +125 °C	Unit
				Min	Typ <mark>[1]</mark>	Max	Min	Мах	-
t _{pd}	propagation delay	Yn to Z, Z to Yn; see Figure 13	[2]						
		V _{CC} = 1.2 V		-	25	-	-	-	ns
		V _{CC} = 2.0 V		-	9	17	-	20	ns
		V _{CC} = 2.7 V		-	6	13	-	15	ns
		$V_{CC} = 3.0 \text{ V} \text{ to } 3.6 \text{ V}$	<u>[3]</u>	-	5	10	-	12	ns
	V _{CC} = 4.5 V		-	4	9	-	10	ns	
		V _{CC} = 6.0 V		-	3	8	-	8	ns
t _{en}	enable time	E to Yn, Z; see Figure 14	[2]						
		V _{CC} = 1.2 V		-	145	-	-	-	ns
		V _{CC} = 2.0 V		-	49	94	-	112	ns
		V _{CC} = 2.7 V		-	36	69	-	83	ns
		$V_{CC} = 3.0 \text{ V} \text{ to } 3.6 \text{ V}; C_L = 15 \text{ pF}$	[3]	-	23	-	-	-	ns
		$V_{CC} = 3.0 \text{ V} \text{ to } 3.6 \text{ V}$	[3]	-	28	55	-	66	ns
		V _{CC} = 4.5 V		-	25	47	-	56	ns
		V _{CC} = 6.0 V		-	19	38	-	43	ns
		Sn to Yn; see <u>Figure 14</u>	[2]						
		V _{CC} = 1.2 V		-	140	-	-	-	ns
		V _{CC} = 2.0 V		-	48	90	-	107	ns
		V _{CC} = 2.7 V		-	35	66	-	79	ns
		$V_{CC} = 3.0 \text{ V}$ to 3.6 V; $C_L = 15 \text{ pF}$	<u>[3]</u>	-	22	-	-	-	ns
		$V_{CC} = 3.0 \text{ V} \text{ to } 3.6 \text{ V}$	<u>[3]</u>	-	27	53	-	63	ns
		V _{CC} = 4.5 V		-	24	45	-	54	ns
		$V_{CC} = 6.0 V$		-	18	34	-	41	ns

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Symbol	Parameter	Conditions		-40	°C to +85	S °C	−40 °C t	o +125 °C	Unit
				Min	Typ <mark>[1]</mark>	Max	Min	Max	
t _{dis}	disable time	Ē to Yn, Z; see Figure 14	[2]						
		V _{CC} = 1.2 V		-	145	-	-	-	ns
		V _{CC} = 2.0 V		-	51	93	-	110	ns
		V _{CC} = 2.7 V		-	38	69	-	82	ns
		V_{CC} = 3.0 V to 3.6 V; C _L = 15 pF	<u>[3]</u>	-	25	-	-	-	ns
		V _{CC} = 3.0 V to 3.6 V	<u>[3]</u>	-	30	56	-	66	ns
		V _{CC} = 4.5 V		-	29	48	-	56	ns
		V _{CC} = 6.0 V		-	21	37	-	44	ns
		Sn to Yn; see <u>Figure 14</u>	[2]						
		V _{CC} = 1.2 V		-	115	-	-	-	ns
		V _{CC} = 2.0 V		-	41	73	-	90	ns
		V _{CC} = 2.7 V		-	31	54	-	67	ns
		V_{CC} = 3.0 V to 3.6 V; C _L = 15 pF	<u>[3]</u>	-	20	-	-	-	ns
		V _{CC} = 3.0 V to 3.6 V	<u>[3]</u>	-	24	44	-	54	ns
		V _{CC} = 4.5 V		-	22	37	-	46	ns
		V _{CC} = 6.0 V		-	17	29	-	36	ns
C _{PD}	power dissipation capacitance	C_L = 50 pF; f _i = 1 MHz; V ₁ = GND to V _{CC}	<u>[4]</u>	-	25	-	-	-	pF

Table 8. Dynamic characteristics ...continued

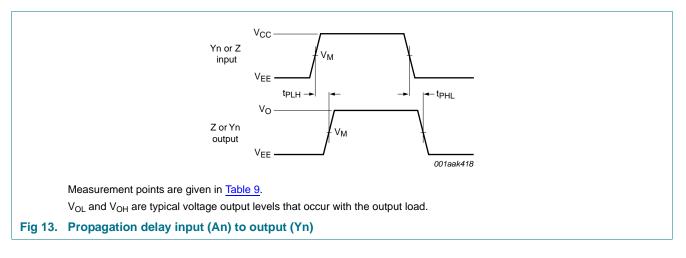
Voltages are referenced to GND (ground = 0 V). For test circuit see <u>Figure 15</u>.

[1] All typical values are measured at T_{amb} = 25 °C.

- [3] Typical values are measured at nominal supply voltage (V_{CC} = 3.3 V).
- $\begin{array}{ll} \label{eq:powerstar} [4] & C_{PD} \text{ is used to determine the dynamic power dissipation } (P_D \text{ in } \mu\text{W}). \\ & P_D = C_{PD} \times V_{CC}{}^2 \times f_i \times \text{N} + \Sigma((C_L + C_{SW}) \times V_{CC}{}^2 \times f_o) \text{ where:} \\ & f_i = \text{input frequency in } \text{MHz}, \ f_o = \text{output frequency in } \text{MHz} \\ & C_L = \text{output load capacitance in } \text{pF} \\ & C_{SW} = \text{maximum switch capacitance in } \text{pF}; \\ & V_{CC} = \text{supply voltage in } \text{Volts} \\ & \text{N} = \text{ number of inputs switching} \\ & \Sigma(C_L \times V_{CC}{}^2 \times f_o) = \text{sum of the outputs.} \end{array}$

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10.1 Waveforms



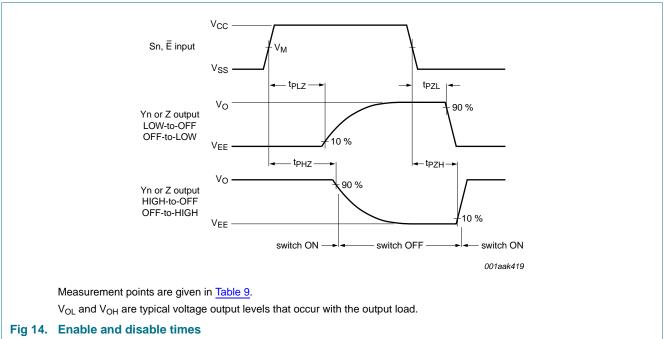


Table 9. **Measurement points**

Supply voltage	Input	Output	Output						
V _{cc}	V _M	V _M	V _X	V _Y					
< 2.7 V	0.5V _{CC}	0.5V _{CC}	V _{OL} + 0.1V _{CC}	$V_{OH} - 0.1V_{CC}$					
2.7 V to 3.6 V	1.5 V	1.5 V	V _{OL} + 0.3 V	V _{OH} – 0.3 V					
> 3.6 V	0.5V _{CC}	0.5V _{CC}	V _{OL} + 0.1V _{CC}	$V_{OH} - 0.1 V_{CC}$					

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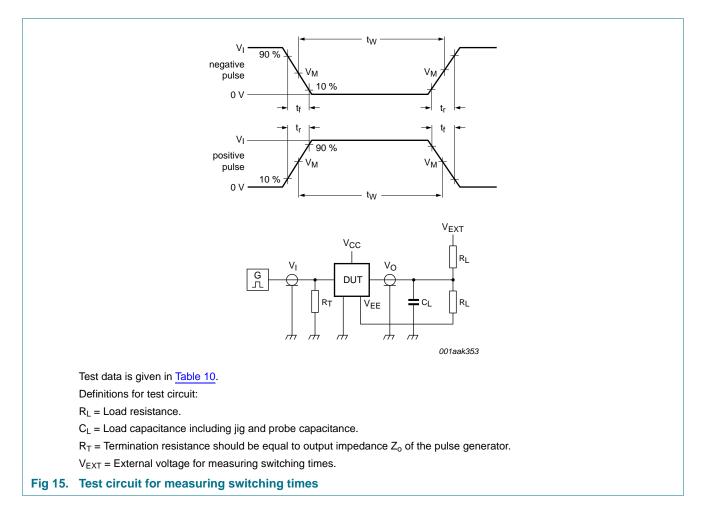


Table 10. Test data

Supply voltage	Input		Load		V _{EXT}			
V _{cc}	VI	t _r , t _f	CL	RL	t _{PHL} , t _{PLH}	t _{PZH} , t _{PHZ}	t _{PZL} , t _{PLZ}	
< 2.7 V	V _{CC}	≤ 6 ns	50 pF	1 kΩ	open	V _{EE}	2V _{CC}	
2.7 V to 3.6 V	2.7 V	≤ 6 ns	15 pF, 50 pF	1 kΩ	open	V _{EE}	2V _{CC}	
> 3.6 V	V _{CC}	≤6 ns	50 pF	1 kΩ	open	V _{EE}	2V _{CC}	

8-channel analog multiplexer/demultiplexer

10.2 Additional dynamic parameters

Table 11. Additional dynamic characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V); $V_I = GND$ or V_{CC} (unless otherwise specified); $t_r = t_f \le 6.0$ ns; $T_{amb} = 25$ °C.

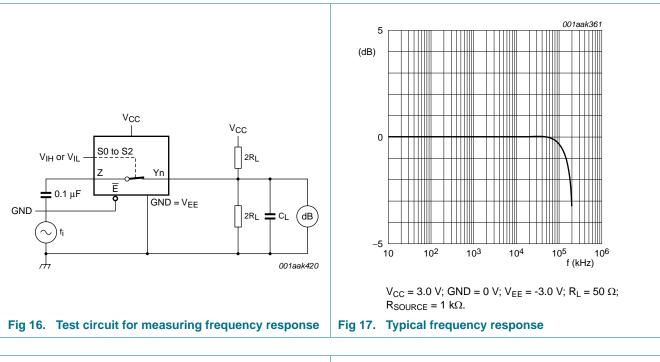
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
THD	total harmonic distortion	$f_i = 1 \text{ kHz}; C_L = 50 \text{ pF}; R_L = 10 \text{ k}\Omega; \text{ see } \frac{\text{Figure 20}}{10 \text{ km}}$					
		V _{CC} = 3.0 V; V _I = 2.75 V (p-p)		-	0.8	-	%
		V _{CC} = 6.0 V; V _I = 5.5 V (p-p)		-	0.4	-	%
		$f_i = 10 \text{ kHz}; C_L = 50 \text{ pF}; R_L = 10 \text{ k}\Omega; \text{ see } \frac{\text{Figure 20}}{10 \text{ kHz}}$					
		V _{CC} = 3.0 V; V _I = 2.75 V (p-p)		-	2.4	-	%
		V _{CC} = 6.0 V; V _I = 5.5 V (p-p)		-	1.2	-	%
f _(-3dB)	-3 dB frequency response	$C_L = 50 \text{ pF}; R_L = 50 \Omega; \text{ see } \frac{\text{Figure 16}}{1000}$	[1]				
		V _{CC} = 3.0 V		-	180	-	MHz
		V _{CC} = 6.0 V		-	200	-	MHz
α_{iso}	isolation (OFF-state)	$f_i = 1 \text{ MHz}; C_L = 50 \text{ pF}; R_L = 600 \Omega; \text{ see } \frac{\text{Figure } 18}{18}$	[2]				
		V _{CC} = 3.0 V		-	-50	-	dB
		V _{CC} = 6.0 V		-	-50	-	dB
V _{ct}	crosstalk voltage	between digital inputs and switch; $f_i = 1 \text{ MHz}$; C _L = 50 pF; R _L = 600 Ω; see Figure 21	[2]				
		V _{CC} = 3.0 V		-	0.11	-	V
		$V_{CC} = 6.0 V$		-	0.12	-	V
Xtalk	crosstalk	between switches; $f_i = 1 \text{ MHz}$; $C_L = 50 \text{ pF}$; $R_L = 600 \Omega$; see <u>Figure 22</u>					
		V _{CC} = 3.0 V		-	-60	-	dB
		$V_{CC} = 6.0 V$		-	-60	-	dB

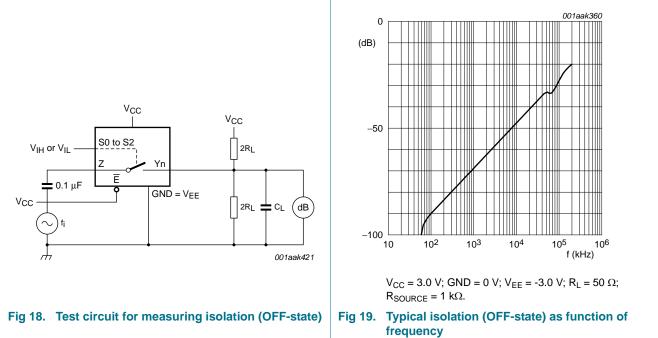
[1] Adjust f_i voltage to obtain 0 dBm level at output for 1 MHz (0 dBm = 1 mW into 50 Ω).

[2] Adjust f_i voltage to obtain 0 dBm level at output for 1 MHz (0 dBm = 1 mW into 600 Ω).

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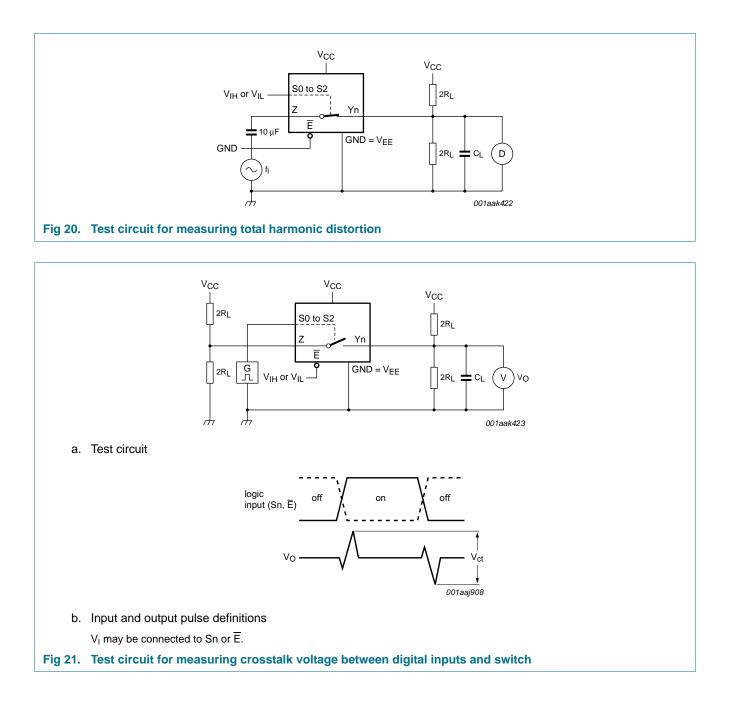


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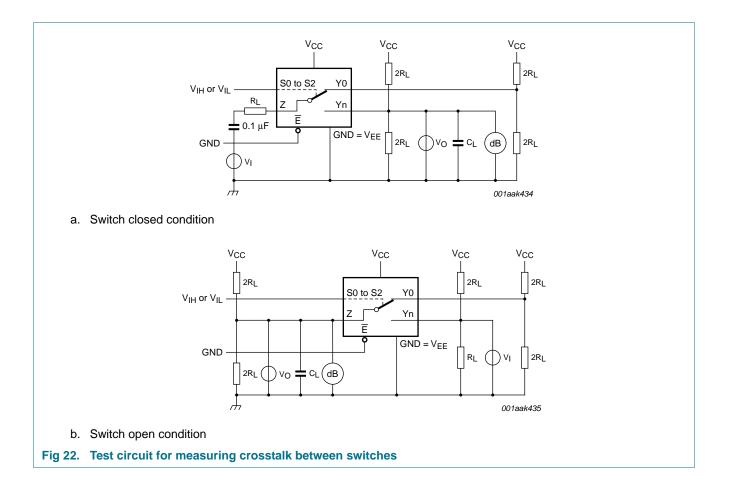
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11. Package outline

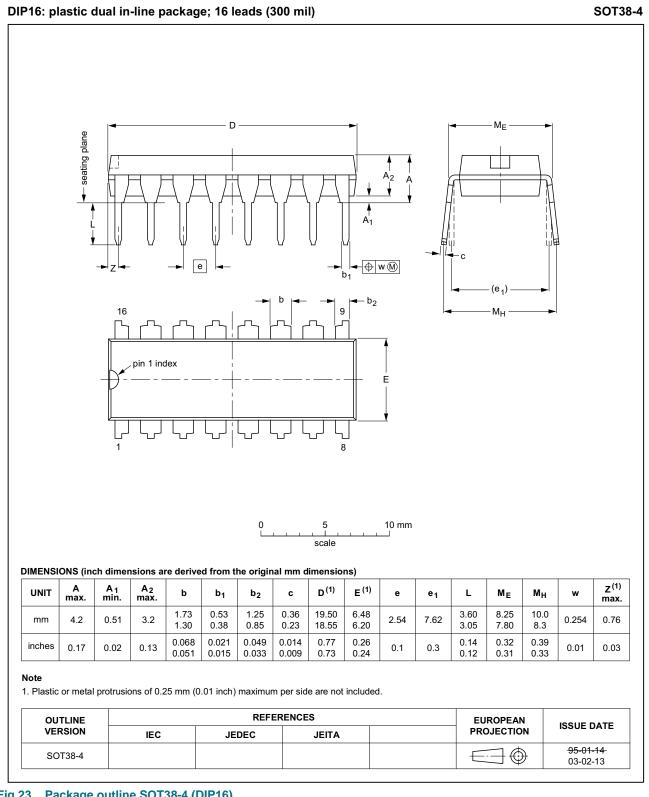


Fig 23. Package outline SOT38-4 (DIP16)

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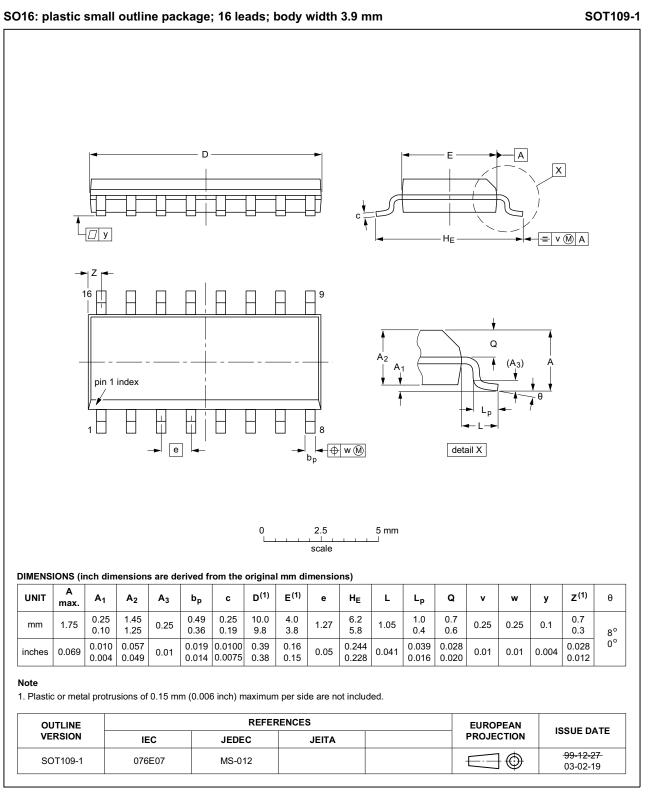


Fig 24. Package outline SOT109-1 (SO16)

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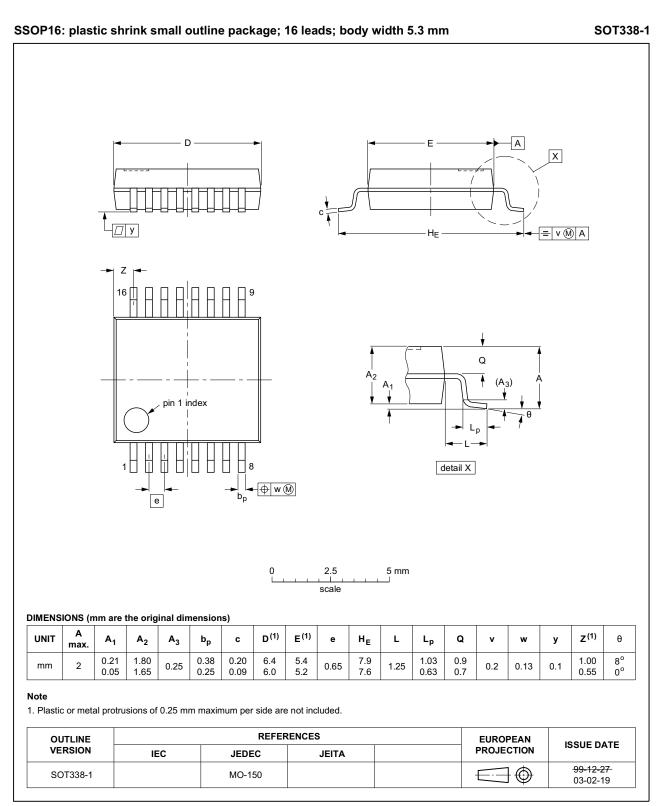


Fig 25. Package outline SOT338-1 (SSOP16)

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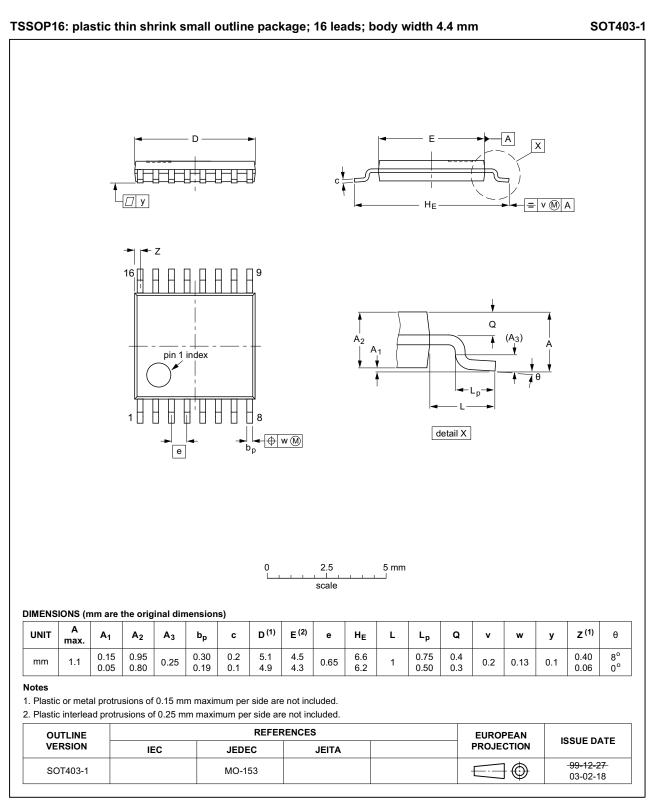
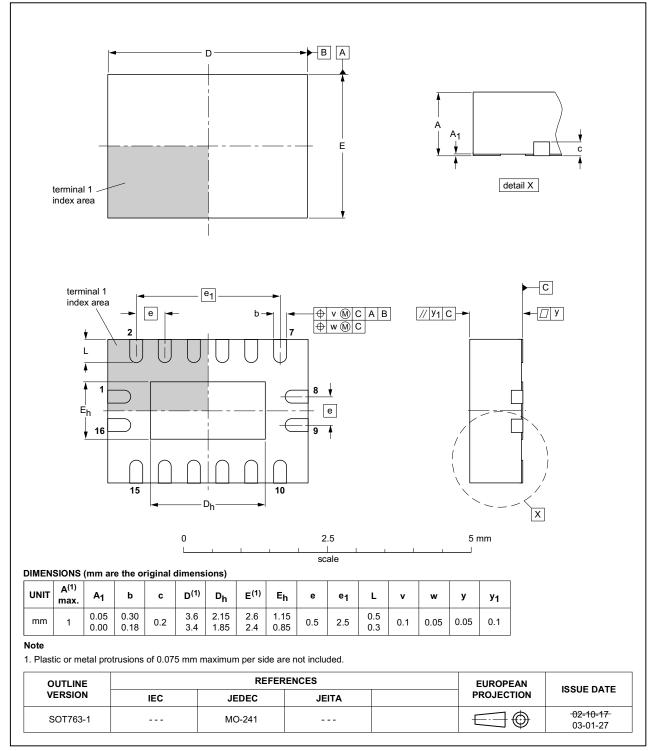


Fig 26. Package outline SOT403-1 (TSSOP16)

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DHVQFN16: plastic dual in-line compatible thermal enhanced very thin quad flat package; no leads; 16 terminals; body 2.5 x 3.5 x 0.85 mm SOT763-1

Fig 27. Package outline SOT763-1 (DHVQFN16)

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12. Abbreviations

Table 12. Abbreviations			
Acronym	Description		
CMOS	Complementary Metal-Oxide Semiconductor		
ESD	ElectroStatic Discharge		
НВМ	Human Body Model		
MM	Machine Model		
TTL	Transistor-Transistor Logic		

13. Revision history

Table 13.Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes			
74LV4051 v.5	20140917	Product data sheet	-	74LV4051 v.4			
Modifications:	<u>Figure 7</u> : Figure note added for DHVQFN16 package						
74LV4051 v.4	20090810	Product data sheet	-	74LV4051 v.3			
Modifications:	Indifications: • The format of this data sheet has been redesigned to comply with the new identity guing of NXP Semiconductors.						
	 Legal texts have been adapted to the new company name where appropriate. 						
	 Added type number 74LV4051BQ (DHVQFN16 package) 						
74LV4051 v.3	19960623	Product specification	-	74LV4051 v.2			
74LV4051 v.2	19970715	Product specification	-	74LV4051 v.1			

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Document status[1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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[2] The term 'short data sheet' is explained in section "Definitions".

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